

# *VACUUM EFFECT ON BULK ETCH RATE OF POLYMER TRACK DETECTORS*

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# EXPERIMENTAL SETUP



- Vacuum chamber of ~30 liters volume (preliminary and turbomolecular pump);
- Target holder - support for PADC detectors (provided by TASL);
- Cf-252 source (20kBq) mounted on the inside part of the window;
- TASL 2 cm x 2.5 cm PADC mounted in the holder.

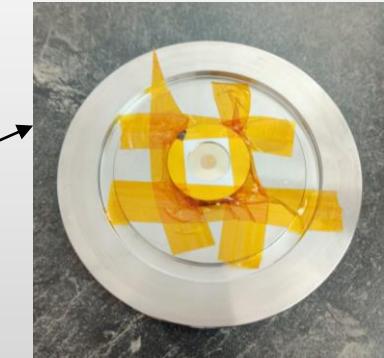


Fig. 2 Cf-252 sources mounted on the window

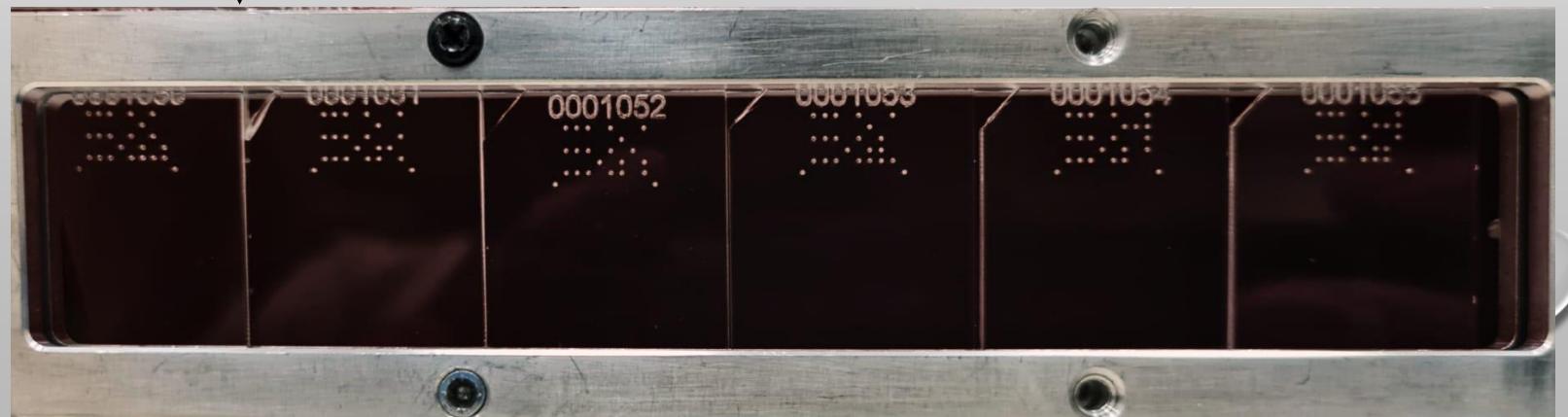
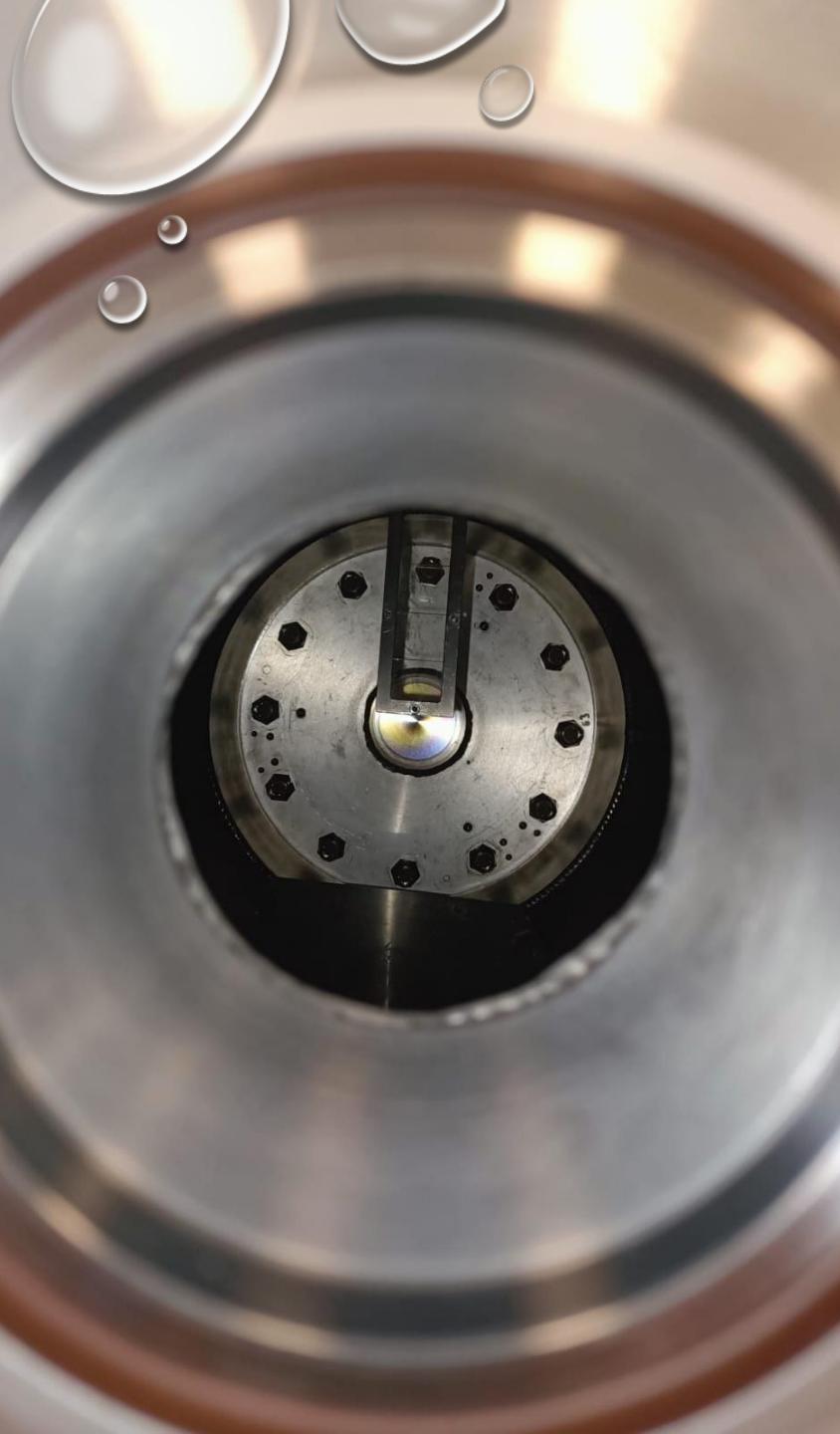


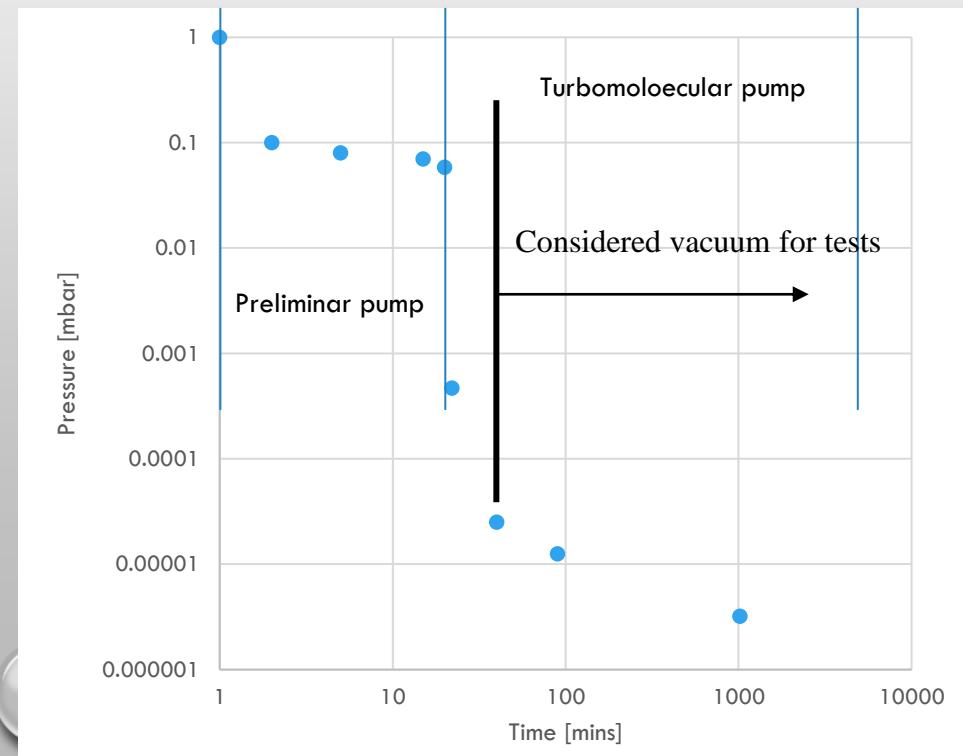
Fig. 3 TASL detectors mounted in the holder



# VACUUM EXPOSURE

- ❖ 4-6 detectors have been placed in vacuum chamber for each test;
- ❖ Preliminary pump achieves the  $10^{-2}$  mbar range in 20', and the turbomolecular one goes to  $10^{-5}$  mbar in 2';
- ❖ Vacuum times varied from 1 minute to almost 17 hours;
- ❖ There should be no changes induced by the vacuum conditions before irradiation is taking place <sup>[3]</sup>;
- ❖ For each test we've been working in two cases: with or without Cf-252 source (for fission fragments or mass difference assessment methods);
- ❖ When the vacuum pressure achieved  $10^{-5}$  mbar, the detectors have been places down for uniform irradiation;

Fig.4 Approximation of vacuum pressure trend



# VACUUM EFFECT ON DETECTOR'S MASS

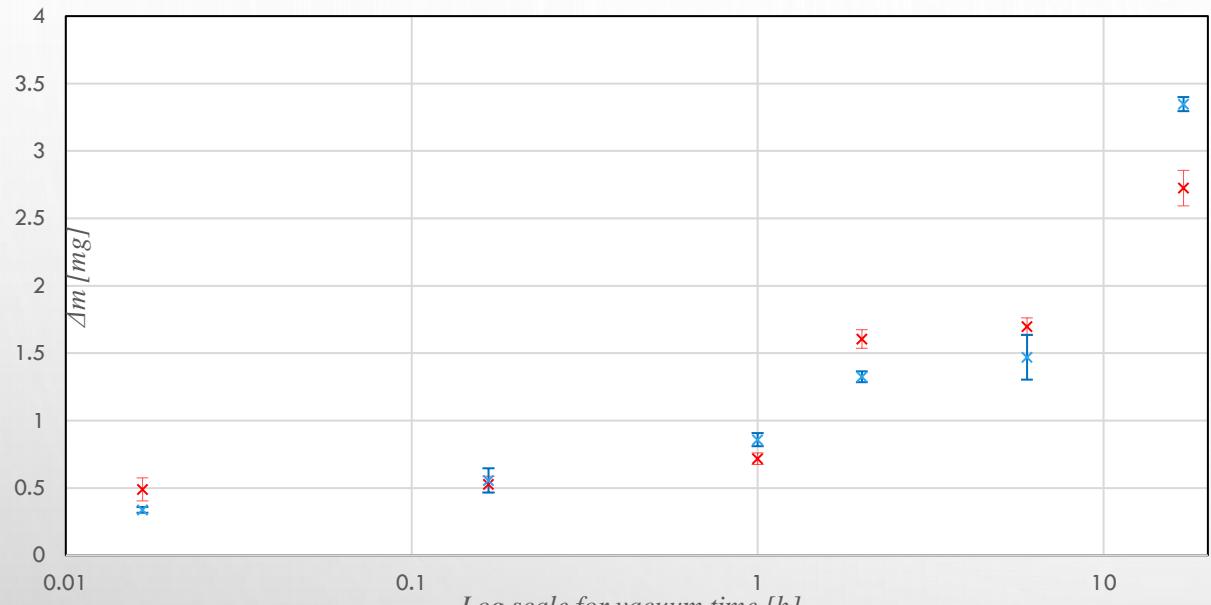


Fig.5 Mass loss during vacuum exposures

Sample code	Context	Atomic concentrations	
1066	Refference sample – kept in the frigde	$69.83 \pm 1.71$	$30.17 \pm 1.08$
1118	No irradiation performed, 6h in vacuum	$69.50 \pm 1.70$	$30.50 \pm 1.09$
1125	Irradiated, 6h in vacuum	$70.24 \pm 1.07$	$29.76 \pm 1.72$

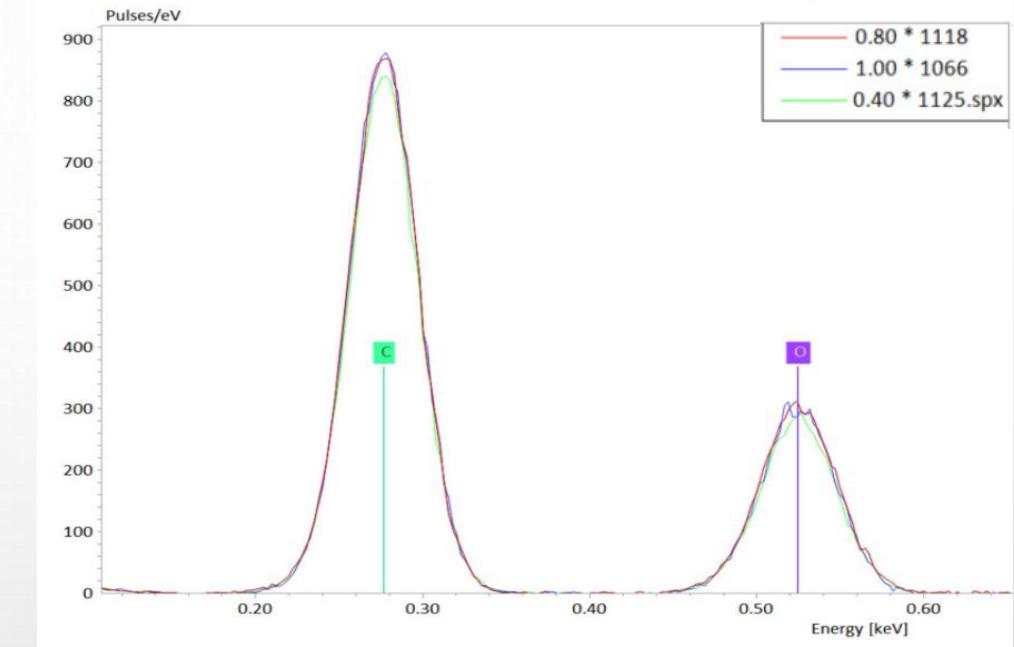
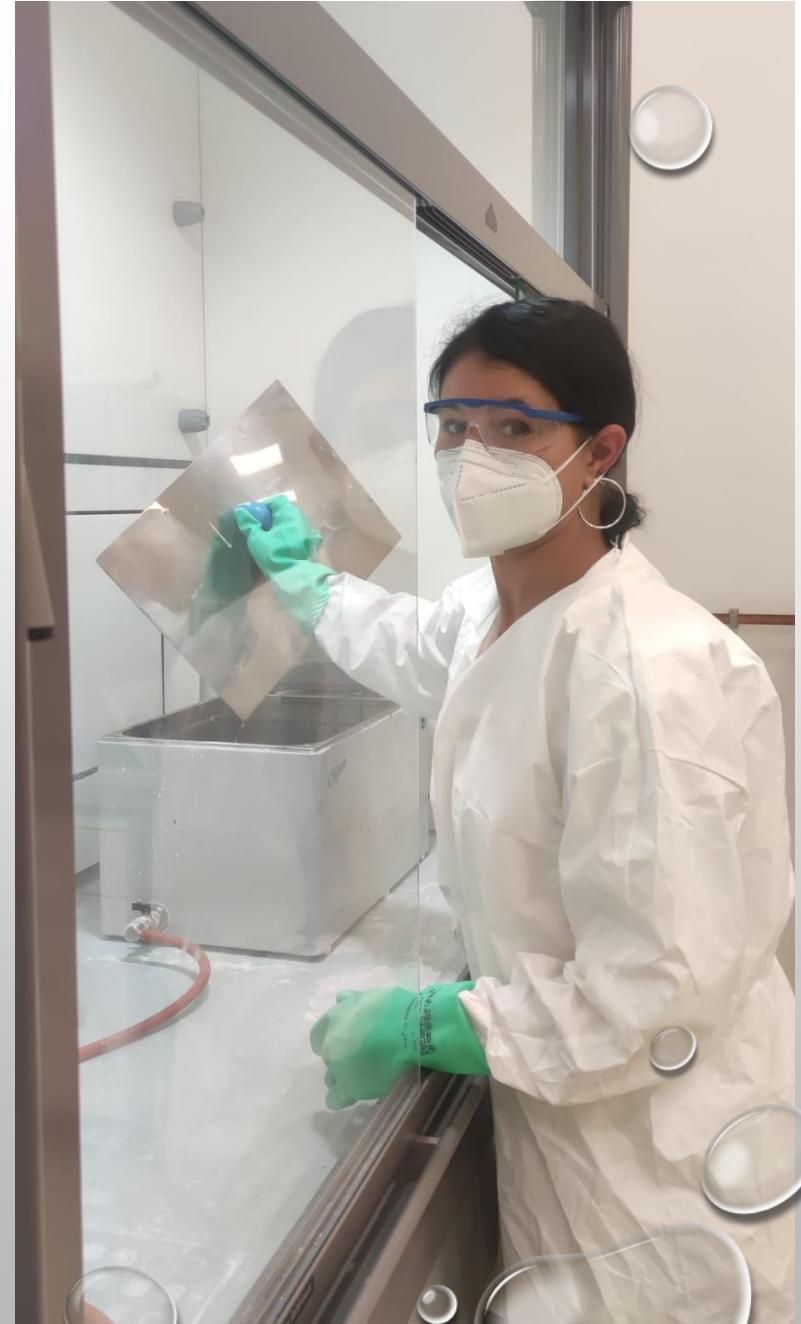


Fig.6 SEM analysis for vacuum exposed detectors

- Performing aditional irradiation in vacuum did not enhance the material loss process;
- Mass loss could be explained by Hidrogen's desorption or of both C and O in the same ratio.
- The samples have been measured after the vacuum exposure and 20 hours later --► no increase in mass (no re-absorption effect has been induced post-vacuum exposure)

# ETCHING PROCEDURE

- 6.25 M NaOH solution (20 litres), 85°C;
- Assumptions from previous tests: bulk etch rate for TASL detectors (PADC of 2 cm x 2.5 cm bevel-cut forms) –  $V_b \sim 5 \mu\text{m/h}$ ;
- Every etching step included control detectors to estimate the bulk etch rate during each chemical processing;
- For the irradiated detectors we've tried not to remove more than 10  $\mu\text{m}$  in order to apply the fission fragment technique <sup>[1]</sup>;



# Bulk etch rates for non-irradiated detectors

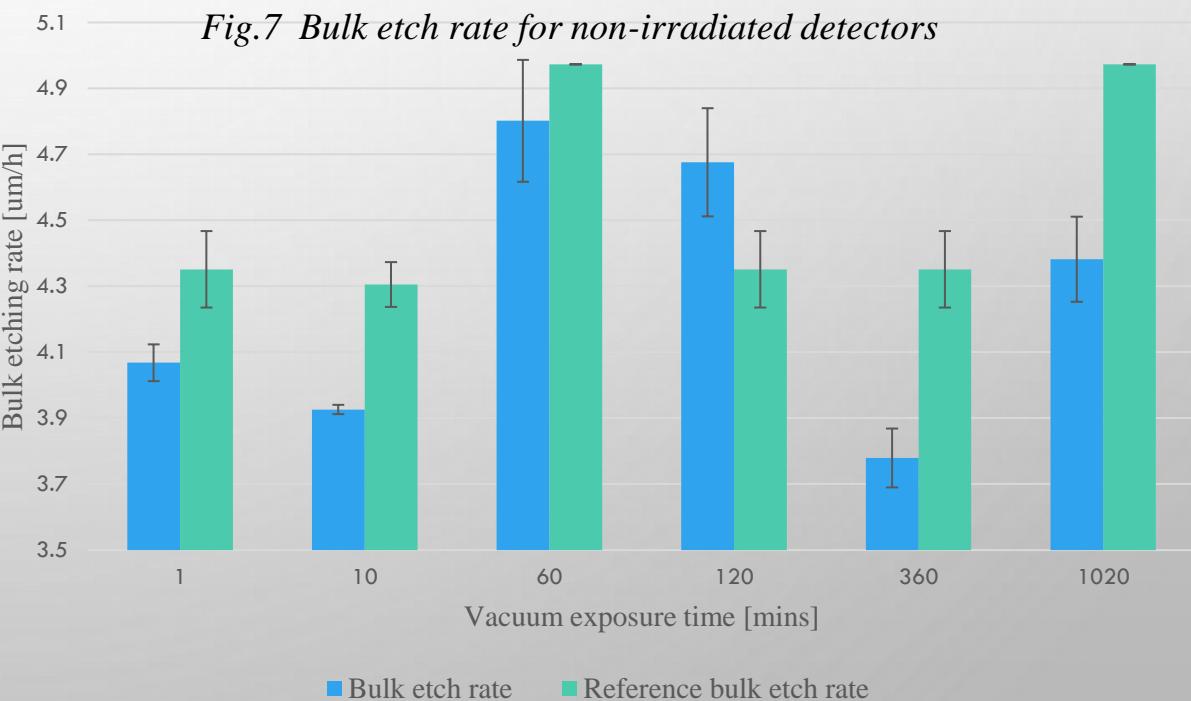
No Irradiation performed – $V_b$ through mass difference method			
Time	$V_b$ [ $\mu\text{m}/\text{h}$ ]	*Control $V_b$ [ $\mu\text{m}/\text{h}$ ]	Relative difference
1 min	$4.068 \pm 0.056$	$4.351 \pm 0.116$	- 6.5 %
10 min	$3.926 \pm 0.014$	$4.305 \pm 0.068$	- 8.8 %
1 h	$4.802 \pm 0.185$	4.973	- 3.44 %
2 h	$4.676 \pm 0.164$	$4.351 \pm 0.116$	7.47 %
6 h	$3.779 \pm 0.089$	$4.351 \pm 0.116$	- 2.4 %
~17 h	$4.382 \pm 0.129$	4.973	- 11.88 %

\* Control bulk etch rate assessed through mass difference method

Assessment through mass difference method:

$$V_B = \frac{m_{\text{after vacuum}} - m_{\text{after etch}}}{2A\rho t} \quad [1]$$

- constant density ( $\rho$ ) of  $1.31 \text{ g/cm}^3$ ;
- constant area ( $A$ ) of  $477 \text{ mm}^2$ ;
- $t = 2 \text{ h}$  of etching;



# Bulk etch rates for irradiated detectors

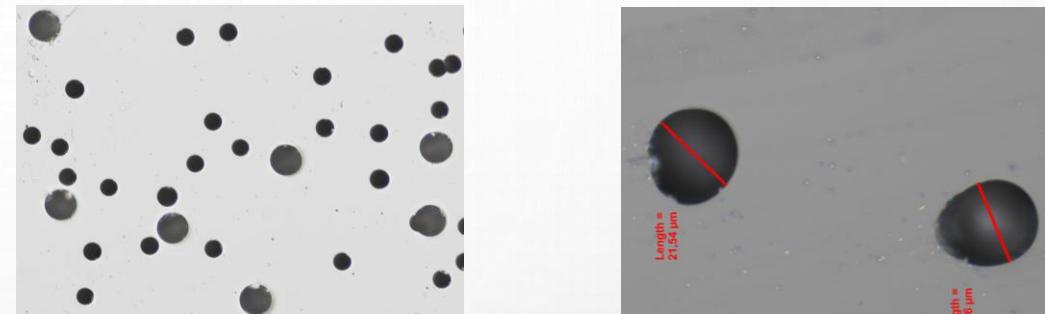
Irradiation performed with 20 kBq Cf-252 source - V <sub>b</sub> through fission fragments method			
Time	V <sub>b</sub> [μm / h]	*Control V <sub>b</sub> [μm / h]	Relative difference [%]
1 min	4.729 ± 0.037	4.305 ± 0.068	9.85 %
10 min	4.119 ± 0.020	4.351 ± 0.116	- 5.33 %
1 h	4.521 ± 0.117	4.973	- 9.09 %
2 h	4.107 ± 0.011	4.351 ± 0.116	- 5.61 %
6 h	4.11 ± 0.029	4.351 ± 0.116	- 5.54 %
~17 h	4.052 ± 0.025	4.351 ± 0.116	- 6.87 %

\* Control bulk etch rate assessed through mass difference method

$$V = \sqrt{1 + \left(\frac{D}{2h}\right)^2 \left(\frac{2}{1 - \left(\frac{d}{2h}\right)^2}\right)^2} \quad [2]$$

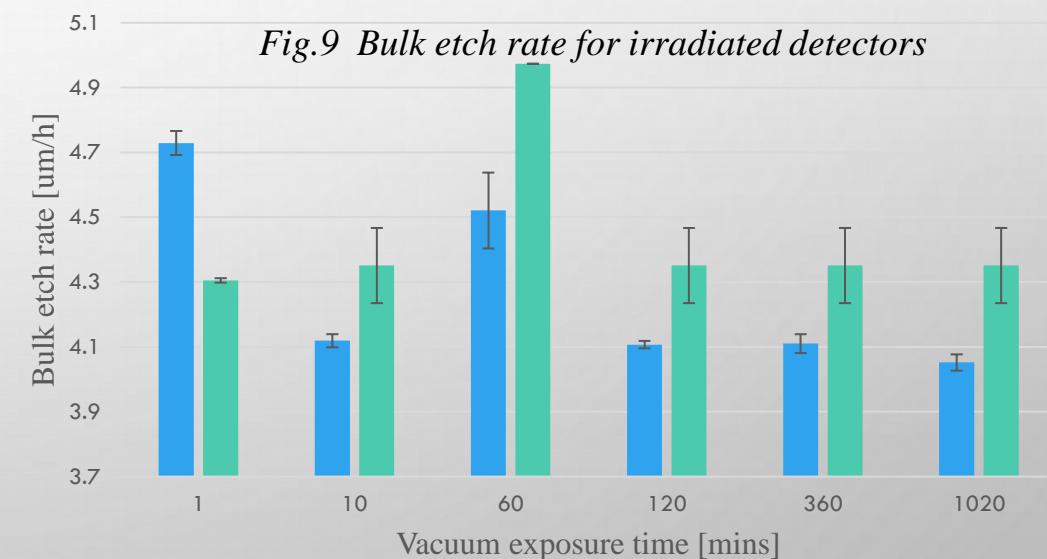
→ **V = 1.195 ± 0.052**  
for a removed layer h = 8.22 μm

Fig. 8 Alpha particles and fission fragments tracks



$$D_{ff} = 2 * Vb * t^{[2]}$$

Fig.9 Bulk etch rate for irradiated detectors



■ Bulk etch rate for irradiated detectors

■ Reference bulk etch rate

# SEM analysis of etched detectors

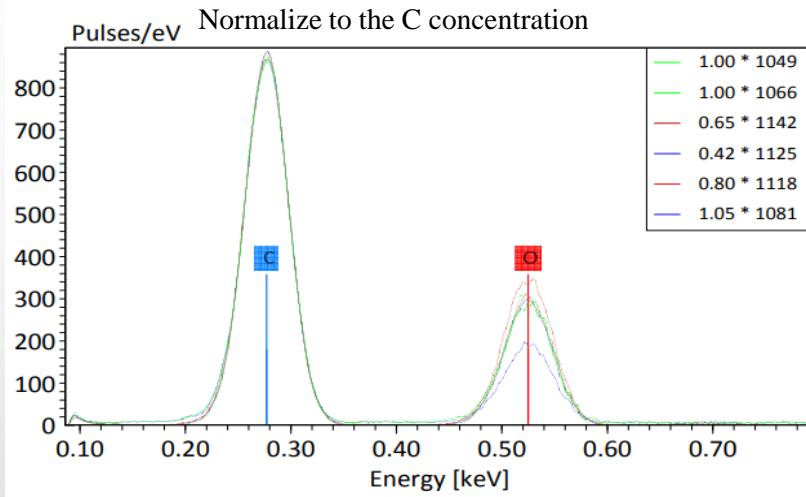


Fig.10 C&O spectra throughout SEM assessment

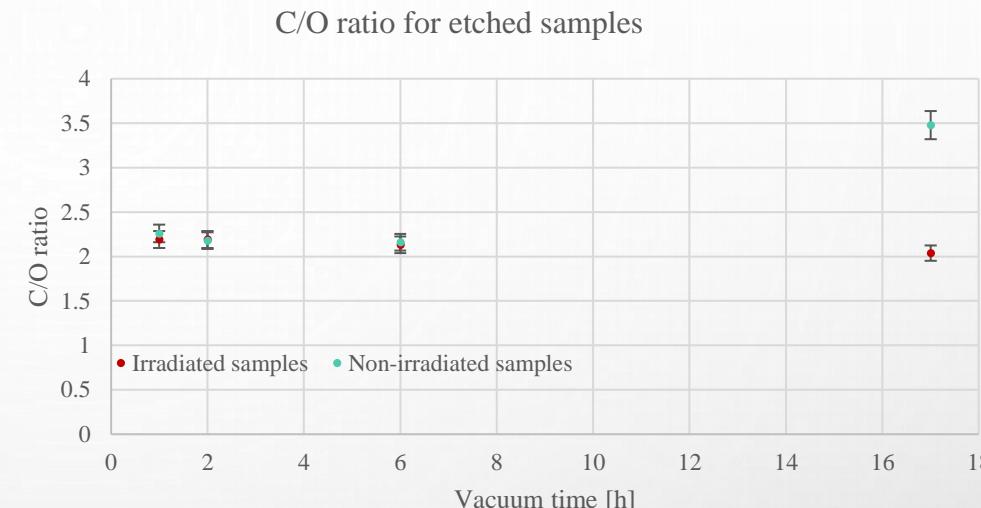


Fig.11 C/O atomic ratios for the etched detectors

Sample code	Context	Atomic concentrations	
1066	Reference sample – kept in the fridge	$69.83 \pm 1.71$	$30.17 \pm 1.08$
1118	No irradiation performed, 6h in vacuum	$69.50 \pm 1.70$	$30.50 \pm 1.09$
1081	No irradiation performed, 17h in vacuum, etched	$77.67 \pm 1.93$	$22.33 \pm 0.85$
1066	Reference sample etched	$69.83 \pm 1.71$	$30.17 \pm 1.08$
1125	Irradiated, 6h in vacuum, etched	$70.24 \pm 1.07$	$29.76 \pm 1.72$
1142	Irradiated, 17h in vacuum, etched	$67.09 \pm 1.63$	$32.91 \pm 1.16$

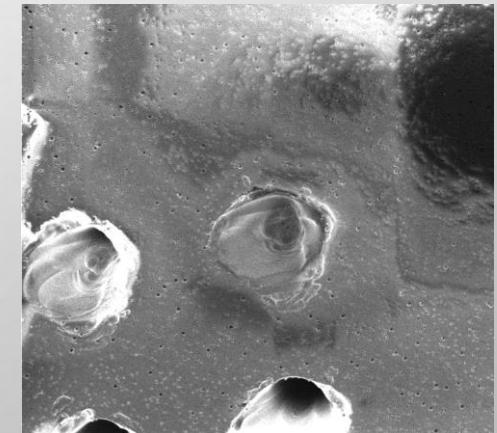
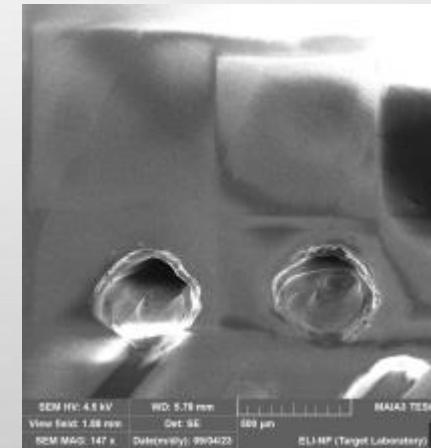


Fig.12 Alpha particles tracks from SEM analysis

# CONCLUSION & OUTLOOK FOR FUTURE RESEARCH

- 1) Mass loss increases with the time of vacuum exposure (and pressure), which may affect the assumption used in mass difference method. → *Constant vacuum pressure-time steps should be considered, in order to establish a correlation between the pressure level, exposure time and mass loss.*
- 2) There is no a so called “elastic effect” induced by the vacuum – detectors prove the same lower mass for hours later after the extraction. → *Look for parameters that may induce temporary stress in the material.*
- 3) Bulk etch rate changes have been noted when irradiation is performed in vacuum. Most of the cases (w/ 2 exemptions) have shown lower values for detectors bulk etch rate comparing to the control ones. → *As long as there is no re-absorption effect, all the detectors should be etched together.*
- 4) No explicit impact of additional irradiation has been proven on the mass loss process during vacuum time comparing to the case when no irradiation has been performed.
- 5) Samples simply kept in vacuum have shown an increasing C/O ratio (+46%) after the etching, while the vacuum + irradiated ones proved a lower value for the same ratio (-15%); → *Further studies need to be performed for sensitivity assessment / activation energy? -> EURADOS CR-39 Quality Task Studies?*



# BIOGRAPHY

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2. M. Bolzonella , I. Ambrožov', M. Caresana , N. Gibbens, P. Gilvin, F. Mariotti, A. Savary, A. Stabilini, F.A. Vittoria , E.G. Yukihara, M.-A. Chevallier, neutron personal dosimetry using polyallyl diglycol carbonate (PADC): current status, best practices and proposed research, physics open 12 (2022) 100114
3. Golovchenko, A. N., & Tretyakova, S. P. (1992). Registration properties of different types of CR-39 in vacuum conditions of irradiation. International Journal of Radiation Applications and Instrumentation. Part D. Nuclear Tracks and Radiation Measurements, 20(3), 521–523.

*Thank you for your attention!*